

Search Notes

Application/Control No.

10/635,314

Examiner

Rick K. Chang

Applicant(s)/Patent under
Reexamination

ONITSUKA ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	281.5,739, 740,760,8 30,832,83 1	3/20/2006	RC
248	309.1		
	309.2		
269	903		
	47,52		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east search	3/20/2006	RC